

SIGC15T60

IGBT³ Chip

FEATURES:

600V Trench & Field Stop technology

WWW.DZ

- low $V_{CE(sat)}$
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

- power module
- discrete components



Applications:

drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC15T60	600V	30A	3.92 x 3.88 mm ²	sawn on foil	Q67050- A4335-A101

Raster size	3.92 x 3.88				
Emitter pad size	3.154 x 3.154	mm ²			
Gate pad size	0.608 x 1.083	一天面			
Area total / active	15.2 / 10.7				
Thickness	70	μm			
Wafer size	150	mm			
Flat position	0				
Max. possible chips per wafer	890 pcs				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm AlSiCu				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, <500μm				
Reject ink dot size	Ø 0.65mm; max 1.2mm				
Recommended storage environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



SIGC15T60

MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit		
Collector-emitter voltage, T _j = 25 °C	V _{CE}	600	V		
DC collector current, limited by T _{jmax}	I _C	1)	Α		
Pulsed collector current, t_p limited by T_{jmax}	I _{cpuls}	90	А		
Gate emitter voltage	V_{GE}	±20	V		
Operating junction and storage temperatur	$T_{\rm j},~T_{\rm stg}$	-40 +175	°C		
SC data, $V_{GE} = 15V$, $V_{CC} = 360V$	Tvj = 150°C	to	6	μs	
	Tvj = 25°C	tp	8	μο	

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
Turumeter			min.	typ.	max.	0
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0 V , I_{C} = 2 mA	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =30A	1.1	1.5	1.9	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I_C =430 μ A , V_{GE} = V_{CE}	5.0	5.8	6.5	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V , V_{GE} =0V			1.6	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			300	nA
Integrated gate resistor	R _{Gint}			none		Ω

ELECTRICAL CHARACTERISTICS (verified by design/characterization):

Parameter	Symbol	Conditions	Value			Unit
i arameter	Joynnoon	Conditions	min.	typ.	max.	
Input capacitance	Ciss	V _{CE} =25V,		1630		pF
Output capacitance	Coss	$V_{GE}=0V$,		108		
Reverse transfer capacitance	Crss	f=1MHz		50		

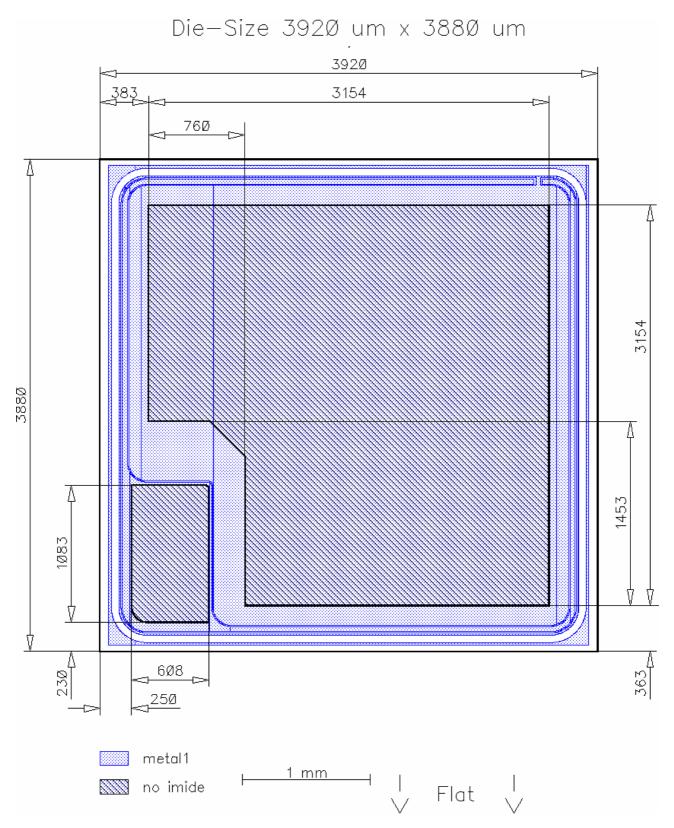
SWITCHING CHARACTERISTICS (verified by design/characterization), inductive load

Parameter	Symbol	Conditions	Value 2)			Unit
raiailletei	Symbol	Conditions	min.	typ.	max.	
Turn-on delay time	$t_{ exttt{d(on)}}$	<i>T</i> _j =125°C		20		ns
Rise time	t _r	$V_{\rm CC} = 300 \text{V}$		15		1
Turn-off delay time	$t_{d(off)}$	I _C =30A, V _{GE} =-15/15V,		140		1
Fall time	t _f	$R_{\rm G}$ = 15 Ω		50		1

 $^{^{2)}}$ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:



Edited by INFINEON Technologies AI PS DD CLS, L7551A, Edition 2, 27.01.2005



SIGC15T60

FURTHER ELECTRICAL CHARACTERISTICS	:	
This chip data sheet refers to the device data sheet		
DESCRIPTION:		
AQL 0,65 for visual inspection according to failu	ire catalog	
Electrostatic Discharge Sensitive Device accord	ling to MIL-STD 883	
Test-Normen Villach/Prüffeld		

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